

Notice of References Cited	Application/Control No. 10/647,456		Applicant(s)/Patent Under Reexamination IKENAKA ET AL.	
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*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
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*	B	US-2005/0281169	12-2005	Kimura et al.	369/112.01
*	C	US-2002/0159377	10-2002	Saito et al.	369/112.08
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	M	US-			

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NON-PATENT DOCUMENTS

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